Notice of References Cited

Application/Control No.

10/726,473

Examiner

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Applicant(s)/Patent Under
Reexamination
YANG, PANG-LUN

Art Unit
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	А	US-6,330,111	12-2001	Myers, Kenneth J.	359/599
	В	US-6,788,359	09-2004	Lee et al.	349/65
	С	US-5,143,433	09-1992	Farrell, James F.	362/29
	D	US-5,676,453	10-1997	Parkyn et al.	362/260
	Е	US-6,134,092	10-2000	Pelka et al.	361/31
	F	US-2001/0017774	08-2001	Ito et al.	362/31
	G	US-2001/0021110	09-2001	Nakayama et al.	362/247
	Н	US-2002/0097578	07-2002	Greiner, Horst	362/240
	1	US-6,467,931	10-2002	Tenmyo, Yoshiharu	362/223
	J	US-6,601,962	08-2003	Ehara et al.	362/31
	К	US-6,700,633	03-2004	Cho, Chun-Hyun	349/65
	L	US-6,805,468	10-2004	Itoh et al. ·	362/362
	М	US-6,808,279	10-2004	Greiner, Horst	362/30

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					10-10-
	α					
	R					***
	S					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	w	
	x	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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